Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/767,390	WU ET AL.
Examiner	Art Unit
HOAN C. NGUYEN	2871

HOAN C. NGUYEN

	SEARCHED					
Class	Subclass	Date	Examiner			
349	155-157	9/18/2007	CHN			
349	123-124	9/18/2007	CHN			
349	126-129	5/18/2007	CHN			
349	130, 132	5/18/2007	. CHN			
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
all subclasses above and TEXT search		CHN	
	Subclass	Subclass Date	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	9/18/2007	CHN		